

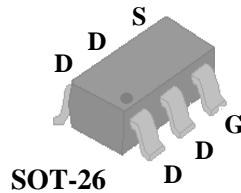


XP15TP1R0Y

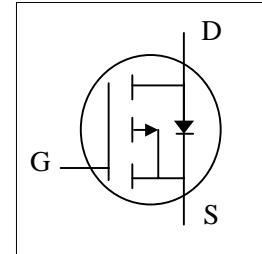
Halogen-Free Product

P-CHANNEL ENHANCEMENT MODE
POWER MOSFET

- ▼ Fast Switching Characteristic
- ▼ Lower Gate Charge
- ▼ Small Footprint & Low Profile Package
- ▼ RoHS Compliant & Halogen-Free



BV_{DSS}	-150V
$R_{DS(ON)}$	1Ω
I_D^3	-1A



Description

XP15TP1R0 series are innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The SOT-26 package is widely used for all commercial-industrial applications.

Absolute Maximum Ratings@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-150	V
V_{GS}	Gate-Source Voltage	+25	V
$I_D @ T_A=25^\circ\text{C}$	Drain Current ³ , $V_{GS} @ 10\text{V}$	-1	A
$I_D @ T_A=70^\circ\text{C}$	Drain Current ³ , $V_{GS} @ 10\text{V}$	-0.78	A
I_{DM}	Pulsed Drain Current ¹	-4	A
$P_D @ T_A=25^\circ\text{C}$	Total Power Dissipation	2	W
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Value	Unit
R_{thj-a}	Maximum Thermal Resistance, Junction-ambient ³	62.5	°C/W

Electrical Characteristics@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_{\text{D}}=-250\mu\text{A}$	-150	-	-	V
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=-10\text{V}$, $I_{\text{D}}=-1\text{A}$	-	0.77	1	Ω
		$V_{\text{GS}}=-6\text{V}$, $I_{\text{D}}=-0.8\text{A}$	-	0.8	1.2	Ω
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=-250\mu\text{A}$	-1.2	-2	-4	V
g_{fs}	Forward Transconductance	$V_{\text{DS}}=-10\text{V}$, $I_{\text{D}}=-1\text{A}$	-	3.4	-	S
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=-120\text{V}$, $V_{\text{GS}}=0\text{V}$	-	-	-25	μA
I_{GSS}	Gate-Source Leakage	$V_{\text{GS}}=\pm 25\text{V}$, $V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Q_g	Total Gate Charge ²	$I_{\text{D}}=-1\text{A}$	-	12	19.2	nC
Q_{gs}	Gate-Source Charge	$V_{\text{DS}}=-75\text{V}$	-	2	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	$V_{\text{GS}}=-10\text{V}$	-	2.5	-	nC
$t_{\text{d}(\text{on})}$	Turn-on Delay Time	$V_{\text{DS}}=-75\text{V}$	-	9	-	ns
t_r	Rise Time	$I_{\text{D}}=-1\text{A}$	-	5	-	ns
$t_{\text{d}(\text{off})}$	Turn-off Delay Time	$R_G=3.3\Omega$	-	24	-	ns
t_f	Fall Time	$V_{\text{GS}}=-10\text{V}$	-	8	-	ns
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}$	-	520	832	pF
C_{oss}	Output Capacitance	$V_{\text{DS}}=-50\text{V}$	-	33	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	20	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ²	$I_{\text{S}}=-1\text{A}$, $V_{\text{GS}}=0\text{V}$	-	-	-1.3	V
t_{rr}	Reverse Recovery Time	$I_{\text{S}}=-1\text{A}$, $V_{\text{GS}}=0\text{V}$, $dI/dt=100\text{A}/\mu\text{s}$	-	40	-	ns
			-	70	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Surface mounted on 1 in² 2oz copper pad of FR4 board, t \leq 10sec ; 156°C/W when mounted on min. copper pad.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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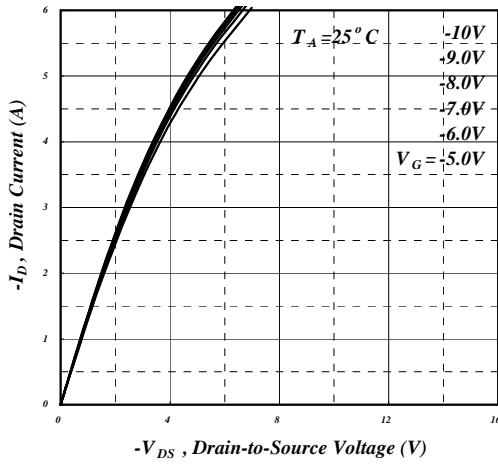


Fig 1. Typical Output Characteristics

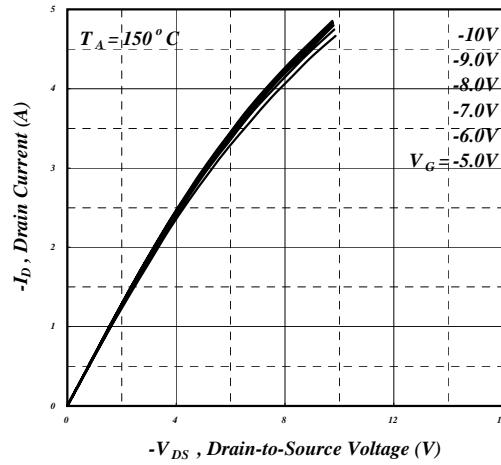


Fig 2. Typical Output Characteristics

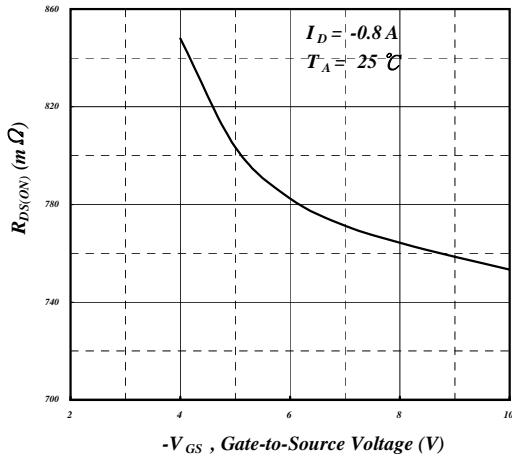


Fig 3. On-Resistance v.s. Gate Voltage

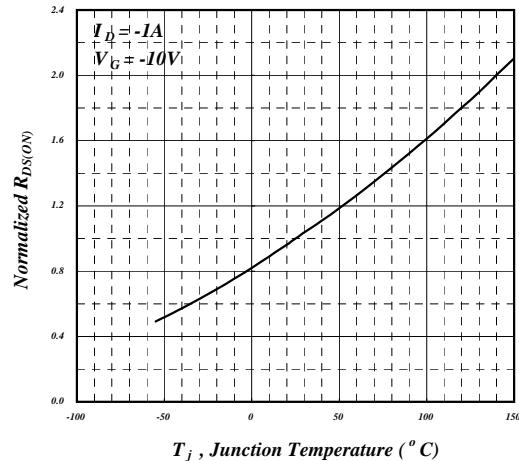


Fig 4. Normalized On-Resistance v.s. Junction Temperature

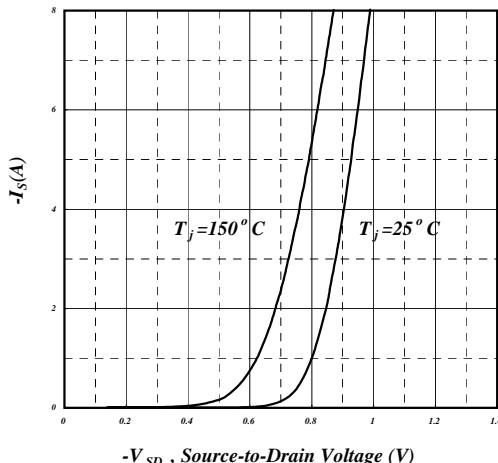


Fig 5. Forward Characteristic of Reverse Diode

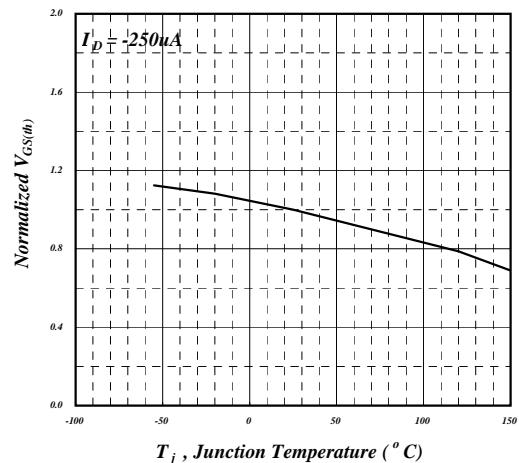


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

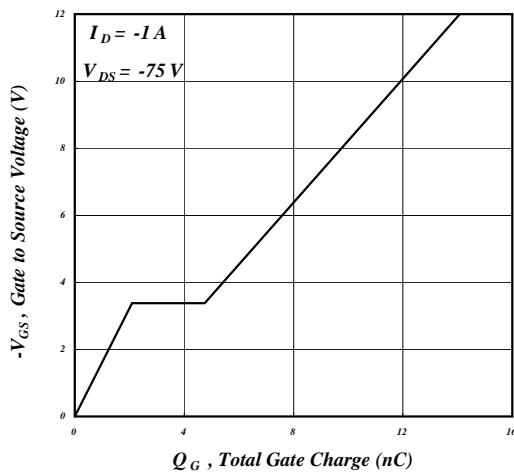


Fig 7. Gate Charge Characteristics

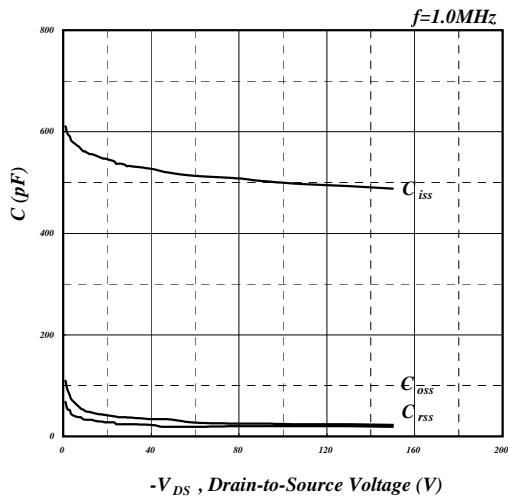


Fig 8. Typical Capacitance Characteristics

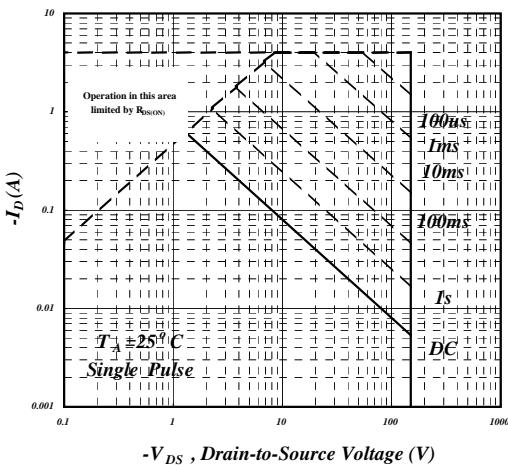


Fig 9. Maximum Safe Operating Area

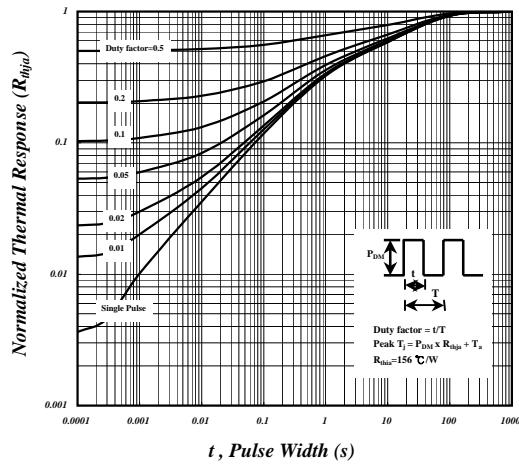


Fig 10. Effective Transient Thermal Impedance

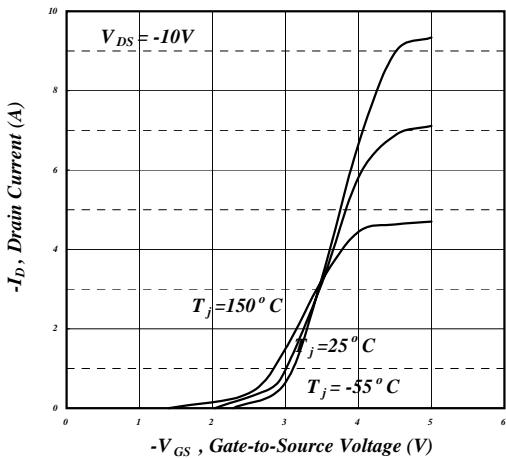


Fig 11. Transfer Characteristics

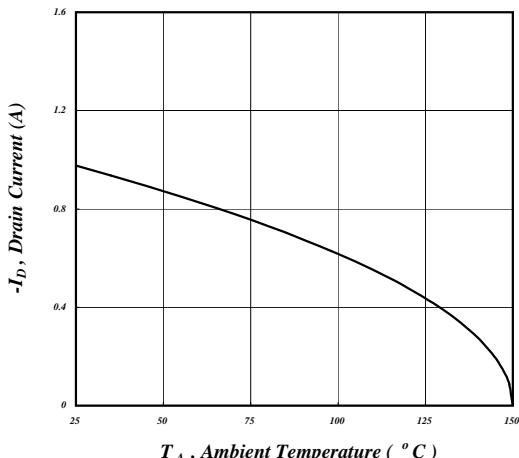


Fig 12. Drain Current v.s. Ambient Temperature

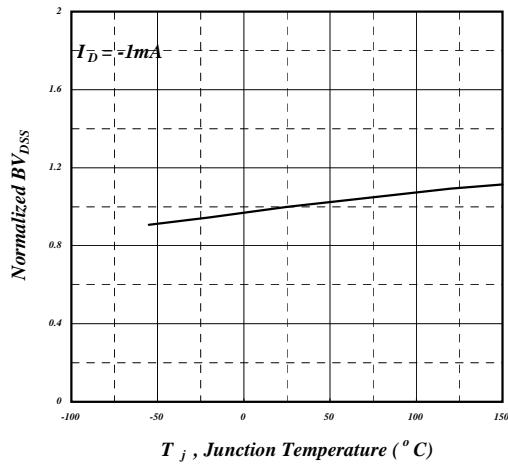


Fig 13. Normalized BV_{DSS} v.s. Junction Temperature

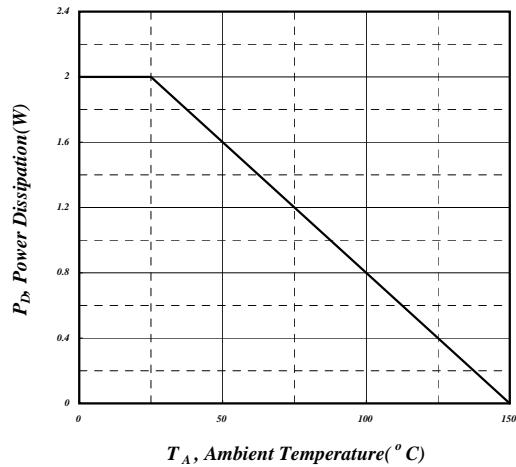


Fig 14. Total Power Dissipation

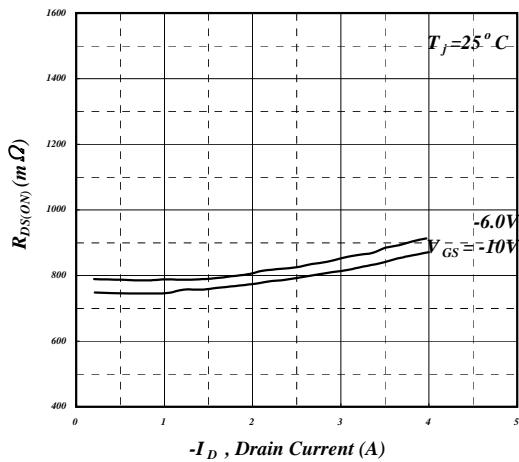
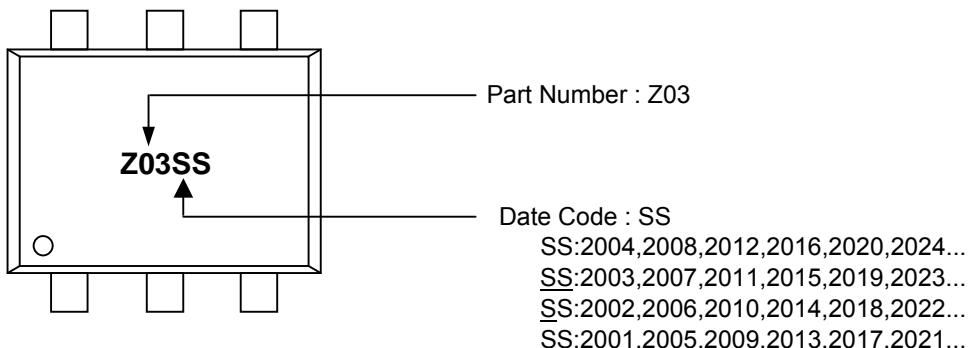
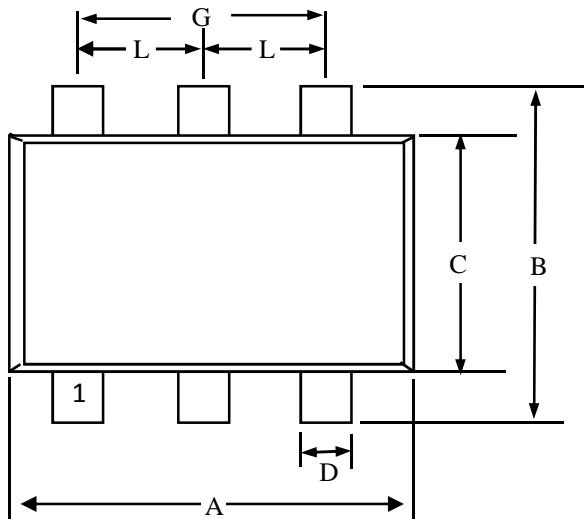


Fig 15. Typ. Drain-Source on State Resistance

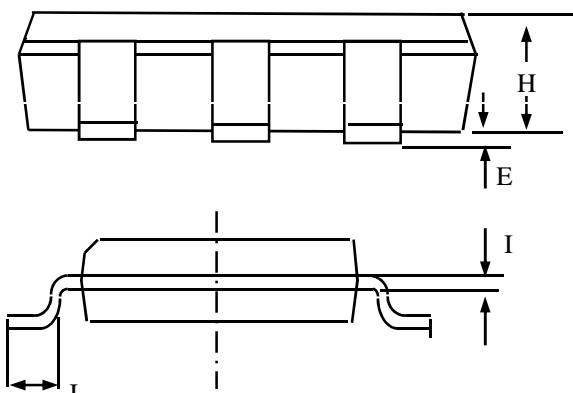
MARKING INFORMATION



Package Outline : SOT-26



SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	2.70	2.90	3.10
B	2.60	2.80	3.00
C	1.40	1.60	1.80
D	0.30	0.40	0.50
E	0.00	0.05	0.10
H	1.00	1.15	1.30
G	—	1.95 (ref.)	—
I	0.10	0.15	0.20
J	0.30	0.45	0.60
L	—	0.95 (ref.)	—



1. All Dimension Are In Millimeters.
2. Dimension Does Not Include Mold Protrusions.

SOT-26 FOOTPRINT :

